TOSHIBA 2SC2240

TOSHIBA TRANSISTOR SILOCON NPN EPITAXIAL TYPE (PCT PROCESS)

2 S C 2 2 4 0

LOW NOISE AUDIO AMPLIFIER APPLICATIONS

The 2SC2240 is a transistor for low frequency and low noise applications. This device is designed to lower noise figure in the region of low signal source impedance, and to lower the pulse noise. This is recommended for the first stages of Equalizer amplifiers.

• Low Noise

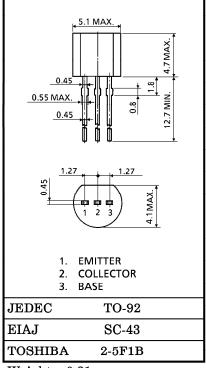
: NF=4dB (Typ.) R_G=100 Ω , V_{CE}=6V, I_C=100 μ A, f=1kHz : NF=0.5dB (Typ.) R_G=1k Ω , V_{CE}=6V, I_C=100 μ A, f=1kHz

Low Pulse Noise : Low 1/f Noise
 High DC Current Gain : hFE=200~700
 High Breakdown Voltage : VCEO=120V

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	120	V
Collector-Emitter Voltage	v_{CEO}	120	V
Emitter-Base Voltage	$V_{ m EBO}$	5	V
Collector Current	$_{ m I_C}$	100	mA
Base Current	I_{B}	20	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	300	mW
Junction Temperature	Tj	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	°C

Unit in mm



Weight: 0.21g

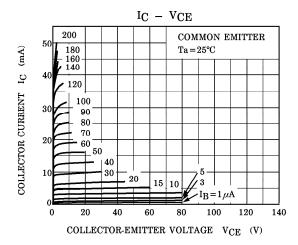
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

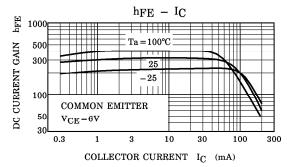
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 120V, I_{E} = 0$	_	_	0.1	μ A
Emitter Cut-off Current	${ m I}_{ m EBO}$	$V_{EB}=5V, I_{C}=0$	_	_	0.1	μ A
Collector-Emitter Breakdown Voltage	V (BR) CEO	$I_C=1$ mA, $I_B=0$	120	_	_	V
DC Current Gain	hFE (Note)	$V_{CE}=6V$, $I_{C}=2mA$	200	_	700	
Collector-Emitter Saturation Voltage	V _{CE} (sat)	$I_C=10$ mA, $I_B=1$ mA	_	_	0.3	V
Base-Emitter Voltage	${ m v_{BE}}$	$V_{CE}=6V$, $I_{C}=2mA$	_	0.65		V
Transition Frequency	${ m f_T}$	$V_{CE}=6V, I_{C}=1mA$	_	100		MHz
Collector Output Capacitance	${f C_{ob}}$	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	_	3.0		рF
Noise Figure	NF	V_{CE} =6V, I_{C} =0.1mA, f=10Hz, R_{G} =10k Ω	_	_	6	
		V_{CE} =6V, I_{C} =0.1mA, f=1kHz, R_{G} =10k Ω	_	_	2	dB
		$V_{CE}=6V$, $I_{C}=0.1$ mA, $f=1$ kHz, $R_{G}=100\Omega$	_	4		

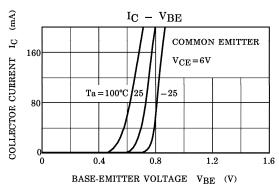
Note: hff Classification GR: 200~400, BL: 350~700

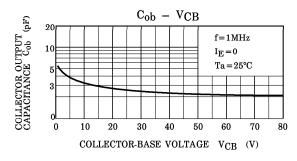
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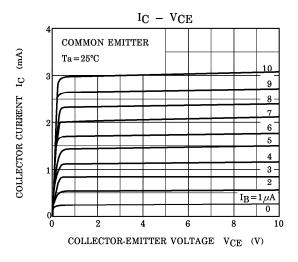
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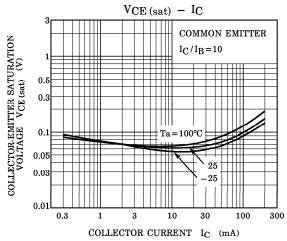


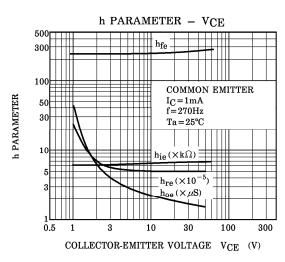












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